

<b>Notice of References Cited</b>	Application/Control No. 10/532,376		Applicant(s)/Patent Under Reexamination LICH ET AL.	
	Examiner Dalena Tran		Art Unit 3664	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,113,138	09-2000	Hermann et al.	280/735
*	B	US-6,161,905	12-2000	Hac et al.	303/146
*	C	US-6,223,114	04-2001	Boros et al.	701/70
*	D	US-6,304,805	10-2001	Onogi, Nobuyoshi	701/36
*	E	US-6,829,524	12-2004	Chee, Wonshik	701/1
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.